

Amendments to the Claims

This listing of claims will replace all prior versions, and listings, of claims in the application.

Listing of Claims:

1. (Original) A semiconductor memory device comprising:
a plurality of memory cells arranged in rows and columns,
said plurality of memory cells being divided into a plurality of storage units each formed of the two memory cells bearing complementary data;
a plurality of bit lines forming pairs each including the two bit lines and arranged corresponding to the columns of said memory cells, respectively;
a plurality of word lines arranged corresponding to the rows of said memory cells, respectively, and extending in a direction crossing said plurality of bit lines; and
a plurality of cell plates provided corresponding to said storage units, respectively, and each isolated at least electrically from the others, wherein
each of said plurality of memory cells includes:
a select transistor connected between the corresponding bit line and a storage node, and being turned on or off in accordance with a voltage on the corresponding word line, and
a capacitor connected between said storage node and the corresponding cell plate.
2. (Original) The semiconductor memory device according to claim 1, wherein
gates of the select transistors in said two memory cells forming the same storage unit are connected to the word lines different from each other, respectively.
3. (Original) The semiconductor memory device according to claim 2, wherein

each of said plurality of memory cells further includes an active region extending in an extending direction of the corresponding bit line and defining a formation region of said select transistor,

said active region extends continuously through a portion between the two memory cells neighboring to each other in the extending direction of the corresponding bit line, and

said semiconductor memory device further comprises:

a bit line contact provided for each of sets each including the neighboring two memory cells, and electrically connecting the corresponding active region to the corresponding bit line.

4. (Original) The semiconductor memory device according to claim 1, wherein gates of the select transistors in said two memory cells forming the same storage unit are connected to the same word line.

5. (Original) The semiconductor memory device according to claim 1, wherein gates of the select transistors in said two memory cells forming the same storage unit are connected to the same word line,

each of said plurality of memory cells further includes an active region extending in a direction intermediate between an extending direction of the corresponding word line and an extending direction of the corresponding bit line, and defining a formation region of said select transistor,

said semiconductor memory device further comprises:

a plurality of bit line contacts connecting the active regions of said plurality of memory cells to the corresponding bit lines, respectively,

said plurality of bit line contacts are aligned in the extending direction of said plurality of word lines, and are provided corresponding to said bit lines, respectively,

the two word lines are arranged between said bit line contacts neighboring to each other in the extending direction of said plurality of bit lines,

said active regions continuously extend through a portion between portions each including the two memory cells and neighboring to each other in the extending direction of said active region, and

said bit line contact is shared by the neighboring two memory cells.

6. (Original) The semiconductor memory device according to claim 5, further comprising:
a plurality of dummy word lines each arranged in a region between said storage nodes of the memory cells which correspond to the different bit line contacts and neighbor to each other in the extending direction of said plurality of bit lines, respectively, and extending in the same direction as said plurality of word lines.

7. (Original) The semiconductor memory device according to claim 6, wherein
each of said plurality of dummy word lines carries a voltage at a predetermined level, and
said active region continuously extends through a region under each of said dummy word lines.

8. (Original) The semiconductor memory device according to claim 7, wherein
each of said plurality of dummy word lines carries a voltage at a predetermined level, and

said active regions substantially extend continuously in the same direction such that said active regions in the memory cells arranged in the neighboring columns, respectively, and belonging to the neighboring rows, respectively, continue to each other.

9. (Original) The semiconductor memory device according to claim 7, wherein each of said plurality of dummy word lines carries a voltage at a predetermined level, and said active regions are continuously formed to be symmetric with respect to each of said dummy word lines.

10. (Original) The semiconductor memory device according to claim 6, wherein each of said plurality of dummy word lines carries a voltage at a predetermined level.

11. (Original) The semiconductor memory device according to claim 6, wherein an interval between said word line and said dummy word line is substantially equal to an interval between said word lines.

12. (Original) A semiconductor memory device comprising:
a plurality of memory cells arranged in rows and columns,
said plurality of memory cells being divided into a plurality of storage units each formed of the two memory cells bearing complementary data;
a plurality of bit lines forming pairs each including the two bit lines and arranged corresponding to the columns of said memory cells, respectively;

a plurality of word lines arranged corresponding to the rows of said memory cells, respectively, and extending in a direction crossing said plurality of bit lines; and

a plurality of cell plates provided corresponding to predetermined sections of said plurality of storage units, respectively, and each isolated at least electrically from the others, wherein

each of said plurality of memory cells includes:

a select transistor connected between the corresponding bit line and a storage node, and being turned on or off in accordance with a voltage on the corresponding word line, and

a capacitor connected between said storage node and the corresponding cell plate.

13. (Original) A semiconductor memory device comprising:

a plurality of memory cells arranged in rows and columns,

said plurality of memory cells being divided into a plurality of storage units each formed of the two memory cells bearing complementary data;

a plurality of bit lines forming pairs each including the two bit lines and arranged corresponding to the columns of said memory cells, respectively;

a plurality of word lines arranged corresponding to the rows of said memory cells, respectively, and extending in a direction crossing said plurality of bit lines; and

a plurality of cell plates provided corresponding to said storage units, respectively, and each isolated at least electrically from the others, wherein

one of said two memory cells forming each of said storage units includes:

a select transistor connected between one of said paired two bit lines and a storage node, and being turned on or off in accordance with a voltage on the corresponding word line, and

a capacitor connected between said storage node and the corresponding cell plate; and

the other of said two memory cells forming said storage unit includes:

a select transistor connected between the other of said paired two bit lines and said cell plate without interposing a capacitor, and being turned on or off in accordance with the voltage on the corresponding word line.

14. (New) The semiconductor memory device according to claim 1, wherein each of said storage units stores one bit data with the two memory cells bearing complementary data, and each of said cell plates is electrically floated.

15. (New) The semiconductor memory device according to claim 12, wherein each of said storage units stores one bit data with the two memory cells bearing complementary data, and each of said cell plates is electrically floated.

16. (New) The semiconductor memory device according to claim 13, wherein each of said storage units stores one bit data with the two memory cells bearing complementary data, and each of said cell plates is electrically floated.